**ON Semiconductor** 

Is Now

# Onsemí

To learn more about onsemi<sup>™</sup>, please visit our website at <u>www.onsemi.com</u>

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product factures, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and asfety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or by customer's technical experts. onsemi products and actal performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiari



**ON Semiconductor®** 

# FDP053N08B N-Channel PowerTrench<sup>®</sup> MOSFET 80 V, 120 A, 5.3 mΩ

# Features

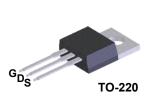
- $R_{DS(on)}$  = 4.2 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 75 A
- Low FOM R<sub>DS(on)</sub> \* Q<sub>G</sub>
- Low Reverse-Recovery Charge, Q<sub>rr</sub> = 62.5 nC
- Soft Reverse-Recovery Body Diode
- Enables High Efficiency in Synchronous Rectification
- Fast Switching Speed
- 100% UIL Tested
- RoHS Compliant

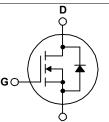
# Description

This N-Channel MOSFET is produced using ON Semiconductor's advanced PowerTrench<sup>®</sup> process that has been tai-lored to minimize the on-state resistance while maintaining superior switching performance.

## Applications

- · Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies





### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

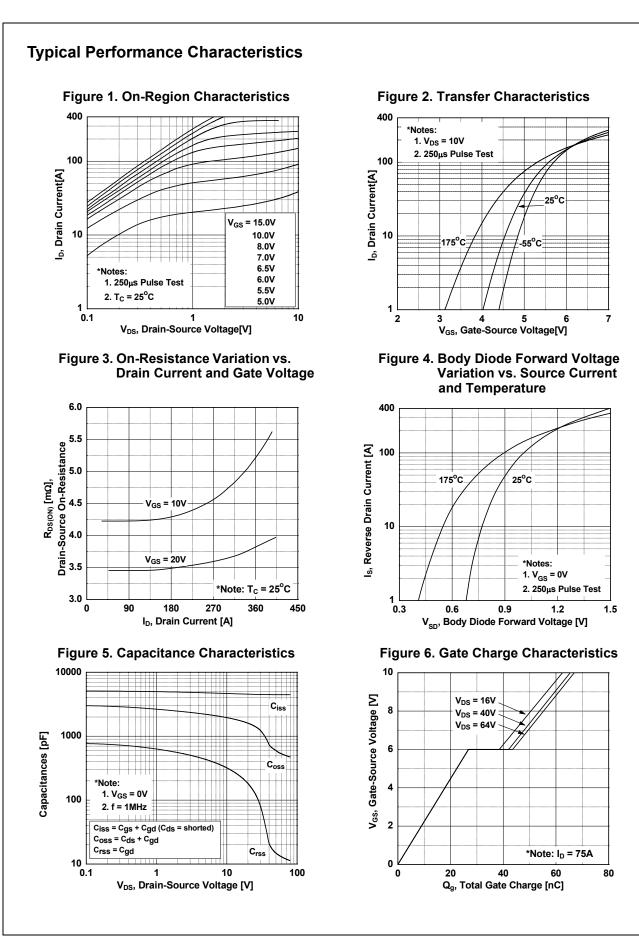
	5 5					
Symbol		Parameter		FDP053N08B	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			80	V	
V <sub>GSS</sub>	Gate to Source Voltage			±20	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C, Silicon L	_imited)	120*		
		- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C, Silicon	- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C, Silicon Limited)			
		- Continuous (T <sub>C</sub> = 25°C, Package	e Limited)	75		
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	480	А	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2		(Note 2)	365	mJ	
dv/dt	Peak Diode Recovery dv/dt (Not		(Note 3)	6.0	V/ns	
P <sub>D</sub>	Dower Dissinction	(T <sub>C</sub> = 25 <sup>o</sup> C)		146	W	
	Power Dissipation	- Derate Above 25°C	- Derate Above 25°C		W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +175	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

\* Package limitation current is 75A.

# **Thermal Characteristics**

Symbol	Parameter	FDP053N08B	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.03	°C/W	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/W	

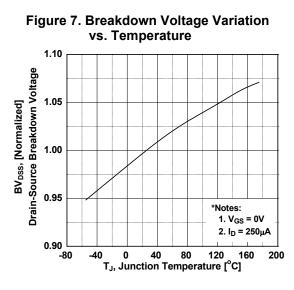
Part NumberTop MarkPackageFDP053N08B-F102FDP053N08BTO-220		Package TO-220	Packing Method     Reel Size       Tube     N/A		Tape Width N/A		Quantity 50 units		
Electrica	l Chara	cteristics T <sub>C</sub> =	= 25ºC unless	otherwise noted.					
Symbol	Parameter			Test Conditions		Min.	Тур.	Max.	Unit
Off Charac	teristics								
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage			I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V		80	-	-	V
∆BV <sub>DSS</sub>	Breakdov	wn Voltage Temperat	ture				0.000		N/00
$/\Delta T_J$	Coefficient			$I_D$ = 250 µA, Referenced to 25°C		-	0.089	-	V/ºC
	Zero Gat	e Voltage Drain Curr	ent	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V		-	-	1	μA
I <sub>DSS</sub>	2010 000	Zero Gate Voltage Drain Current		V <sub>DS</sub> = 64 V, T <sub>C</sub> = 150°C		-	-	500	- μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current			$V_{GS}$ = ±20 V, $V_{DS}$ = 0	V	-	-	±100	nA
On Charac	teristics								
V <sub>GS(th)</sub>	Gate Threshold Voltage			V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA			-	4.5	V
R <sub>DS(on)</sub>		ain to Source On Re	sistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 75 \text{ A}$	-	4.2	5.3	mΩ	
9 <sub>FS</sub>	Forward	Transconductance		V <sub>DS</sub> = 10 V, I <sub>D</sub> = 75 A			100	-	S
Dynamic C	haracto	rietice		1			1		
						-	4480	5960	pF
C <sub>ISS</sub> C <sub>OSS</sub>		put Capacitance		− V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, _ f = 1 MHz		-	740	985	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		٩			-	20.5	-	pF
C <sub>oss(er)</sub>	Energy Related Output Capacitance			V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V		-	1333	-	pF
Q <sub>g(tot)</sub>		e Charge at 10V				-	65.4	85	nC
Q <sub>gs</sub>	Gate to Source Gate Charge   Gate to Drain "Miller" Charge   Gate Plateau Volatge			V <sub>DS</sub> = 40 V, I <sub>D</sub> = 75 A,		-	26.7	-	nC
Q <sub>gd</sub>			V <sub>GS</sub> = 10 V (Note 4)		-	15.3	_	nC	
V <sub>plateau</sub>					-	6.0	_	V	
Q <sub>sync</sub>	Total Gate Charge Sync.		$V_{\rm DS} = 0 \text{ V}, \text{ I}_{\rm D} = 37.5 \text{ A}$		-	52.4	-	nC	
Q <sub>oss</sub>	Output Charge			$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	64.2	-	nC	
ESR	Equivalent Series Resistance (G-S)			f = 1 MHz	-	1.2	-	Ω	
Quitabing			<u> </u>						
Switching		Delay Time					22	74	
t <sub>d(on)</sub>				$V_{DD}$ = 40 V, I <sub>D</sub> = 75 A, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 4.7 Ω		-	32	74	ns
t <sub>r</sub>		Rise Time				-	30		ns
t <sub>d</sub> (off)	Turn-Off	Delay Time			-	44	98 42	ns	
t <sub>f</sub>					(Note 4)	-	10	42	ns
	1	e Characteristic					1		
l <sub>S</sub>	Maximum Continuous Drain to Source Diod					-	-	120*	A
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Fo				-	-	480	A	
V <sub>SD</sub>	Drain to Source Diode Forward Voltage			$V_{GS} = 0 V, I_{SD} = 75 A$	-	-	1.3	V	
t <sub>rr</sub>	Reverse Recovery Time Reverse Recovery Charge			V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 40 V dI <sub>F</sub> /dt = 100 A/μs	-	59.3 62.5	-	ns nC	
2. L = 3 mH, $I_{AS}$ = 3. $I_{SD} \le 100$ A, di/d	: pulse-width lir 15.6 A, starting t ≤ 200 A/μs, V	nited by maximum junction	25°C.			-	62.5	-	



# www.onsemi.com



## Typical Performance Characteristics (Continued)





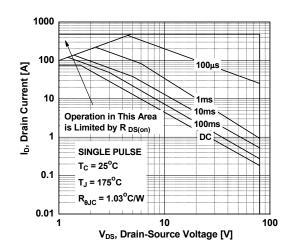
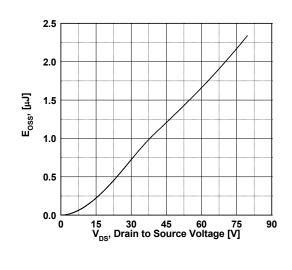
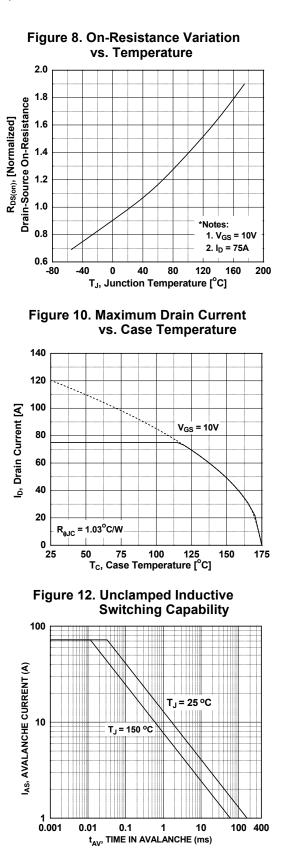
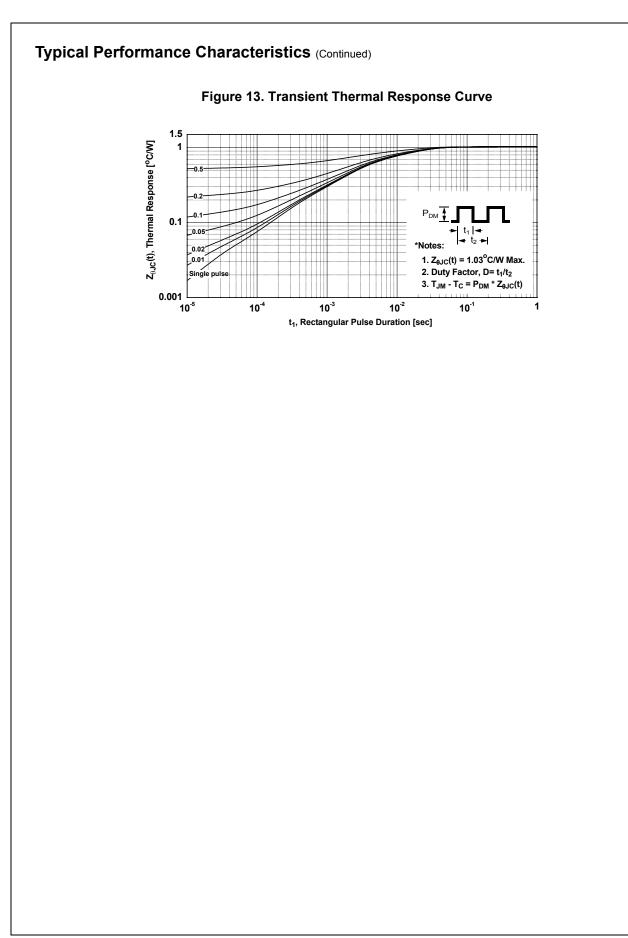


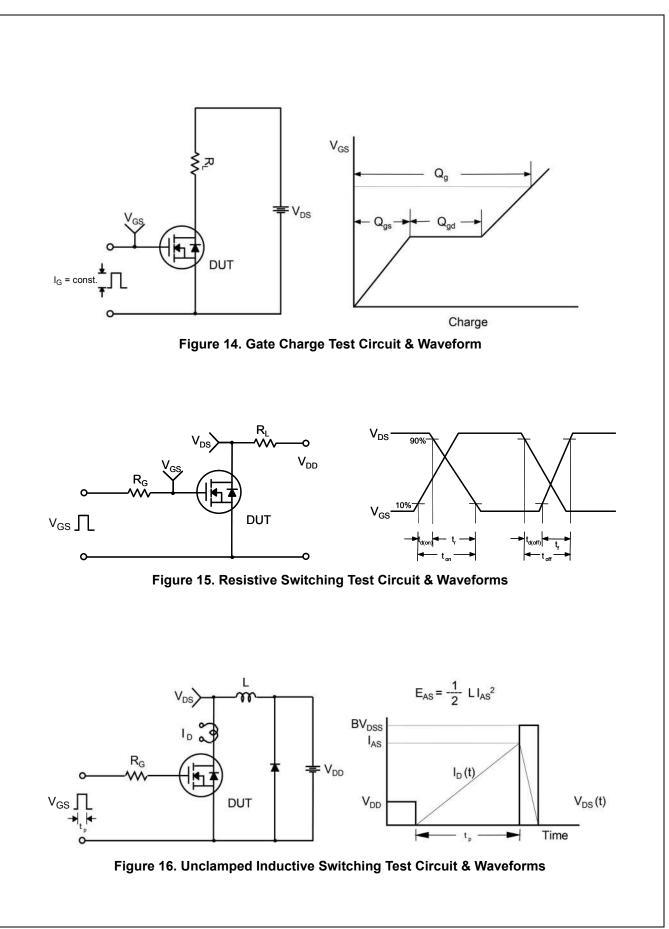
Figure 11. Eoss vs. Drain to Source Voltage





www.onsemi.com





DUT +  $v_{DS}$ a ۱<sub>sd</sub> م L Driver R<sub>G</sub>€ Same Type as DUT Ł v<sub>dd</sub> ∏∏ V<sub>GS</sub> • dv/dt controlled by  $R_{G}$ • I<sub>SD</sub> controlled by pulse period Î Gate Pulse Width  $V_{GS}$ D = Gate Pulse Period 10V (Driver)  $\mathbf{I}_{\text{FM}}$  , Body Diode Forward Current I <sub>SD</sub> di/dt (DUT)  $I_{RM}$ Body Diode Reverse Current  $V_{DS}$ (DUT) Body Diode Recovery dv/dt  $V_{SD}$ V<sub>PD</sub> Body Diode Forward Voltage Drop Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

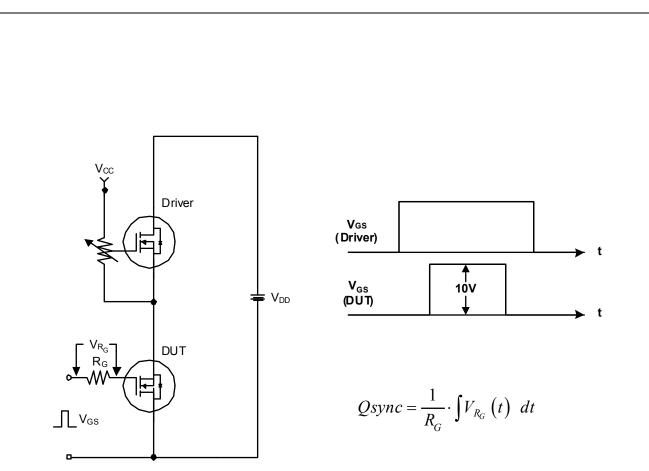
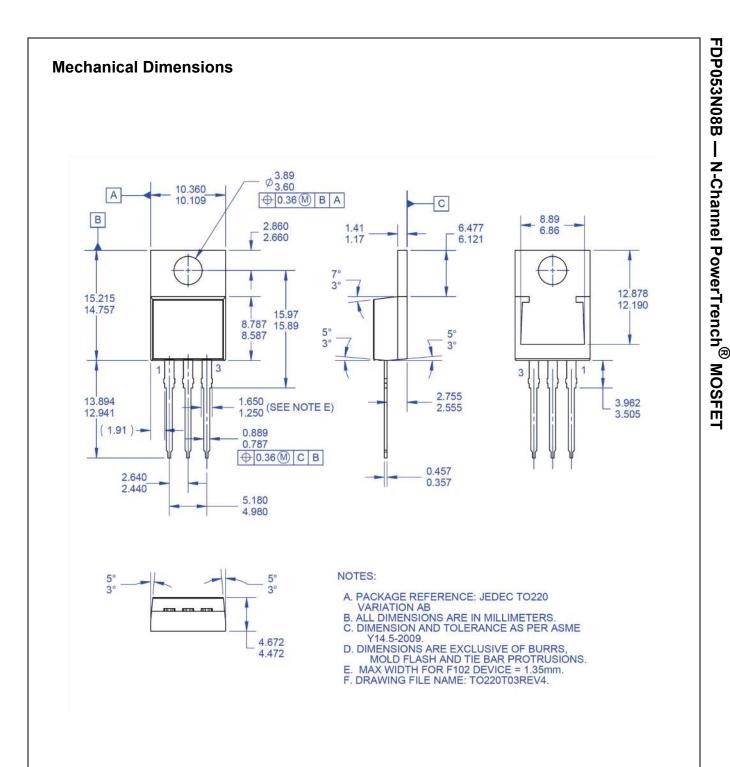


Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms



#### Figure 19. TO-220, Molded, 3-Lead, Jedec Variation AB

Package drawings are provided as a service to customers considering ON Semiconductor components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a ON Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of ON Semiconductor's worldwide terms and conditions, specif-ically the warranty therein, which covers ON Semiconductor products.

www.onsemi.com 9

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor haves, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such uninten

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative